

**Notice of References Cited**

Application/Control No.

10/749,617

Applicant(s)/Patent Under  
Reexamination  
NIKOLOV, NIKOLAI G.

Examiner

Thuy Dao

Art Unit

2192

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Performance monitoring of java applications", Harkema et al., July 2002, pages 114-127, < <a href="http://delivery.acm.org/10.1145/590000/584388/p114-harkema.pdf">http://delivery.acm.org/10.1145/590000/584388/p114-harkema.pdf</a> >.
	V	"Web application security assessment by fault injection and behavior monitoring", Huang et al., May 2003, pages 148-159, < <a href="http://delivery.acm.org/10.1145/780000/775174/p148-huang.pdf">http://delivery.acm.org/10.1145/780000/775174/p148-huang.pdf</a> >.
	W	"Visualizing and AspectJ-enabling eclipse plugins using bytecode instrumentation", Laffra et al., October 2003, pages 70-71, < <a href="http://delivery.acm.org/10.1145/950000/949354/p70-laffra.pdf">http://delivery.acm.org/10.1145/950000/949354/p70-laffra.pdf</a> >.
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.